# MOSFET – Power, Single, N-Channel, μ8FL 30 V, 170 A

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

# **Applications**

- DC-DC Converters
- Power Load Switch
- Notebook Battery Management

# MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

| Param  | Symbol                               | Value                     | Unit            |      |   |
|--|--------------------------------------|---------------------------|-----------------|------|---|
| Drain-to-Source Voltage  | $V_{DSS}$                            | 30                        | V               |      |   |
| Gate-to-Source Voltage   |                                      |                           | $V_{GS}$        | ±20  | V |
| Continuous Drain   |                                      | T <sub>A</sub> = 25°C     | I <sub>D</sub>  | 29   | Α |
| Current R <sub>θJA</sub> (Note 1)  |                                      | T <sub>A</sub> = 85°C     | 1               | 21   |   |
| Power Dissipation $R_{\theta JA}$ (Note 1)                               |                                      | T <sub>A</sub> = 25°C     | P <sub>D</sub>  | 2.7  | W |
| Continuous Drain   |                                      | T <sub>A</sub> = 25°C     | I <sub>D</sub>  | 36   | Α |
| Current R <sub>θJA</sub> ≤ 10 s<br>(Note 1)                              |                                      | T <sub>A</sub> = 85°C     | 1               | 26   |   |
| Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$              | Steady                               | T <sub>A</sub> = 25°C     | P <sub>D</sub>  | 4.2  | W |
| Continuous Drain   | State                                | T <sub>A</sub> = 25°C     | I <sub>D</sub>  | 16   | Α |
| Current R <sub>θJA</sub> (Note 2)  |                                      | T <sub>A</sub> = 85°C     |                 | 12   |   |
| Power Dissipation R <sub>0JA</sub> (Note 2)                              |                                      | T <sub>A</sub> = 25°C     | P <sub>D</sub>  | 0.83 | W |
| Continuous Drain   |                                      | T <sub>C</sub> = 25°C     | I <sub>D</sub>  | 170  | Α |
| Current R <sub>θJC</sub> (Note 1)  |                                      | T <sub>C</sub> = 85°C     |                 | 120  |   |
| Power Dissipation R <sub>θJC</sub> (Note 1)                              |                                      | T <sub>C</sub> = 25°C     | P <sub>D</sub>  | 91   | W |
| Pulsed Drain Current   | T <sub>A</sub> = 25°                 | C, t <sub>p</sub> = 10 μs | I <sub>DM</sub> | 500  | Α |
| Operating Junction and S   | T <sub>J</sub> ,<br>T <sub>stg</sub> | -55 to<br>+150            | °C              |      |   |
| Source Current (Body Did   | I <sub>S</sub>                       | 100                       | Α               |      |   |
| Drain to Source dV/dt  | dV/dt                                | 6.0                       | V/ns            |      |   |
| Single Pulse Drain-to-So (I <sub>L</sub> = 37 A <sub>pk</sub> ) (Note 3) | E <sub>AS</sub>                      | 162                       | mJ              |      |   |
| Lead Temperature for So (1/8" from case for 10 s)                        | TL                                   | 260                       | °C              |      |   |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

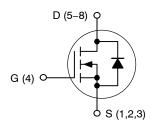


# ON Semiconductor®

#### www.onsemi.com

| V <sub>(BR)DSS</sub> | R <sub>DS(on)</sub> MAX | I <sub>D</sub> MAX |
|----------------------|-------------------------|--------------------|
| 30 V                 | 2.25 mΩ @ 10 V          | 170 A              |
| 30 V                 | 3.1 mΩ @ 4.5 V          | 1708               |

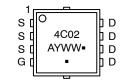
#### **N-Channel MOSFET**





CASE 511AB

## **MARKING DIAGRAM**



4C02 = Specific Device Code A = Assembly Location

Y = Year WW = Work Week ■ = Pb-Free Package

(Note: Microdot may be in either location)

### **ORDERING INFORMATION**

| Device        | Package            | Shipping <sup>†</sup> |
|---------------|--------------------|-----------------------|
| NTTFS4C02NTAG | WDFN8<br>(Pb-Free) | 1500 / Tape &<br>Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

- 2. Surface-mounted on FR4 board using the minimum recommended pad size.
- 3. This is the absolute maximum ratings. Parts are 100% tested at  $T_J = 25^{\circ}C$ ,  $V_{GS} = 10 \text{ V}$ ,  $I_L = 36 \text{ A}$ ,  $E_{AS} = 65 \text{ mJ}$ .

# THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter                                   | Symbol          | Value | Unit  |
|---|-----------------|-------|-------|
| Junction-to-Case (Drain)                    | $R_{	heta JC}$  | 1.4   |       |
| Junction-to-Ambient - Steady State (Note 4) | $R_{\theta JA}$ | 46    | °C/W  |
| Junction-to-Ambient - Steady State (Note 5) | $R_{\theta JA}$ | 150   | -C/VV |
| Junction-to-Ambient - (t ≤ 10 s) (Note 4)   | $R_{	heta JA}$  | 30    |       |

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
   Surface-mounted on FR4 board using the minimum recommended pad size.

# **ELECTRICAL CHARACTERISTICS** (T<sub>.1</sub> = 25°C unless otherwise specified)

| Parameter  | Symbol                              | Test Condition   |                            | Min | Тур   | Max  | Unit  |
|--|-------------------------------------|--|----------------------------|-----|-------|------|-------|
| OFF CHARACTERISTICS  |                                     |  |                            | •   | •     |      | •     |
| Drain-to-Source Breakdown Voltage                            | V <sub>(BR)DSS</sub>                | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$                          |                            | 30  |       |      | V     |
| Drain-to-Source Breakdown Voltage<br>Temperature Coefficient | V <sub>(BR)DSS</sub> /              |  |                            |     | 13.8  |      | mV/°C |
| Zero Gate Voltage Drain Current                              | I <sub>DSS</sub>                    | $V_{GS} = 0 \text{ V}, \qquad T_{J} = 25^{\circ}\text{C}$              |                            |     |       | 1.0  | ,     |
|  |                                     | V <sub>DS</sub> = 24 V   | T <sub>J</sub> = 125°C     |     |       | 10   | μΑ    |
| Zero Gate Voltage Drain Current                              | I <sub>DSS</sub>                    | V <sub>GS</sub> = 0 V,<br>V <sub>DS</sub> = 30 V                       |                            |     |       | 10   | μΑ    |
| Gate-to-Source Leakage Current                               | I <sub>GSS</sub>                    | $V_{DS} = 0 V, V_{G}$  | <sub>S</sub> = 20 V        |     |       | 100  | nA    |
| ON CHARACTERISTICS (Note 6)                                  |                                     |  |                            |     |       |      |       |
| Gate Threshold Voltage                                       | V <sub>GS(TH)</sub>                 | $V_{GS} = V_{DS}, I_D = 250 \mu A$                                     |                            | 1.3 | 1.6   | 2.2  | V     |
| Negative Threshold Temperature Coefficient                   | V <sub>GS(TH)</sub> /T <sub>J</sub> |  |                            |     | 5.0   |      | mV/°C |
| Drain-to-Source On Resistance                                | R <sub>DS(on)</sub>                 | V <sub>GS</sub> = 10 V   | I <sub>D</sub> = 20 A      |     | 1.9   | 2.25 | mΩ    |
|  |                                     | V <sub>GS</sub> = 4.5 V  | I <sub>D</sub> = 20 A      |     | 2.7   | 3.1  |       |
| Forward Transconductance                                     | 9FS                                 | V <sub>DS</sub> = 1.5 V, I <sub>D</sub> = 50 A                         |                            |     | 140   |      | S     |
| Gate Resistance  | $R_{G}$                             |  |                            |     | 0.9   |      | Ω     |
| CHARGES AND CAPACITANCES                                     |                                     |  |                            |     |       |      |       |
| Input Capacitance  | C <sub>ISS</sub>                    |  |                            |     | 2980  |      |       |
| Output Capacitance   | C <sub>OSS</sub>                    | V <sub>GS</sub> = 0 V, f = 1 MH  | łz, V <sub>DS</sub> = 15 V |     | 1200  |      | pF    |
| Reverse Transfer Capacitance                                 | C <sub>RSS</sub>                    |  |                            |     | 55    |      |       |
| Output Charge  | Q <sub>OSS</sub>                    | $V_{GS} = 0 \text{ V}, V_{D}$  | <sub>DD</sub> = 15 V       |     | 25    |      | nC    |
| Capacitance Ratio  | C <sub>RSS</sub> /C <sub>ISS</sub>  | V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 1                             | 5 V, f = 1 MHz             |     | 0.018 |      |       |
| Total Gate Charge  | Q <sub>G(TOT)</sub>                 | V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 50 A |                            |     | 20    |      |       |
| Threshold Gate Charge  | Q <sub>G(TH)</sub>                  |  |                            |     | 4.7   |      |       |
| Gate-to-Source Charge  | $Q_{GS}$                            |  |                            |     | 8.5   |      | nC    |
| Gate-to-Drain Charge   | $Q_{GD}$                            |  |                            |     | 4     |      |       |
| Gate Plateau Voltage   | $V_{GP}$                            |  |                            |     | 2.8   |      | V     |
| Total Gate Charge  | Q <sub>G(TOT)</sub>                 | V <sub>GS</sub> = 10 V, V <sub>DS</sub> =                              |                            | 45  |       | nC   |       |

# **SWITCHING CHARACTERISTICS** (Note 7)

- 6. Pulse Test: pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2%.
- 7. Switching characteristics are independent of operating junction temperatures.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

| Parameter                    | Symbol              | Test Condition   |                     | Min | Тур | Max | Unit |
|------------------------------|---------------------|--|---------------------|-----|-----|-----|------|
| SWITCHING CHARACTERISTICS (N | lote 7)             |  |                     | •   | •   | •   |      |
| Turn-On Delay Time           | t <sub>d(ON)</sub>  |  |                     |     | 12  |     |      |
| Rise Time                    | t <sub>r</sub>      | $V_{GS} = 4.5 \text{ V}, V_{DS}$   | s = 15 V,           |     | 116 |     | ns   |
| Turn-Off Delay Time          | t <sub>d(OFF)</sub> | $I_D = 50 \text{ A}, R_G$  | = 3.0 Ω             |     | 25  |     |      |
| Fall Time                    | t <sub>f</sub>      |  |                     |     | 10  |     | 1    |
| Turn-On Delay Time           | t <sub>d(ON)</sub>  | $V_{GS}$ = 10 V, $V_{DS}$ = 15 V, $I_{D}$ = 50 A, $R_{G}$ = 3.0 $\Omega$ |                     |     | 9   |     | ns   |
| Rise Time                    | t <sub>r</sub>      |  |                     |     | 102 |     |      |
| Turn-Off Delay Time          | t <sub>d(OFF)</sub> |  |                     |     | 33  |     |      |
| Fall Time                    | t <sub>f</sub>      |  |                     |     | 6   |     |      |
| DRAIN-SOURCE DIODE CHARACT   | ERISTICS            |  |                     |     |     |     |      |
| Forward Diode Voltage        | $V_{SD}$            | V <sub>GS</sub> = 0 V,   | $T_J = 25^{\circ}C$ |     | 0.8 | 1.1 |      |
|                              |                     | $I_{S} = 20 \text{ A}$ $T_{J} = 125^{\circ}\text{C}$                     |                     |     | 0.6 |     | V    |
| Reverse Recovery Time        | t <sub>RR</sub>     | $V_{GS}$ = 0 V, $dI_S/dt$ = 100 A/ $\mu$ s, $I_S$ = 50 A                 |                     |     | 42  |     |      |
| Charge Time                  | ta                  |  |                     |     | 21  |     | ns   |
| Discharge Time               | t <sub>b</sub>      |  |                     |     | 21  |     |      |
| Reverse Recovery Charge      | Qpp                 |  |                     | 28  |     | nC  |      |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

<sup>6.</sup> Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.
7. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

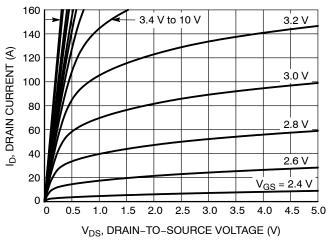


Figure 1. On-Region Characteristics

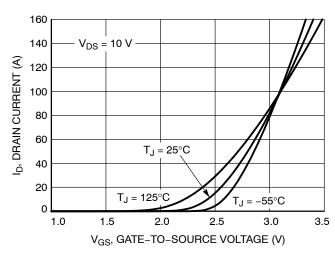


Figure 2. Transfer Characteristics

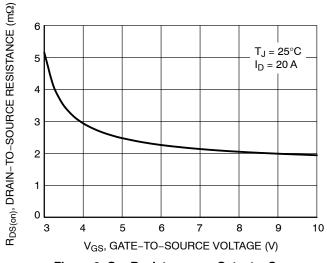


Figure 3. On-Resistance vs. Gate-to-Source Voltage

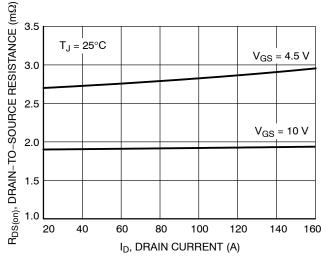


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

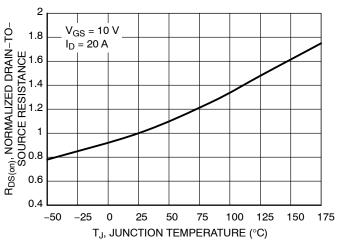


Figure 5. On–Resistance Variation with Temperature

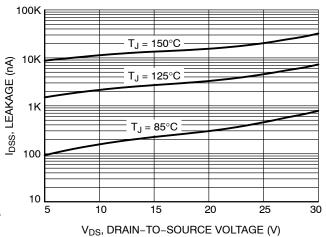


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**

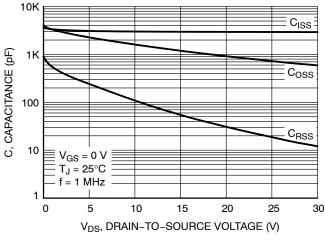


Figure 7. Capacitance Variation

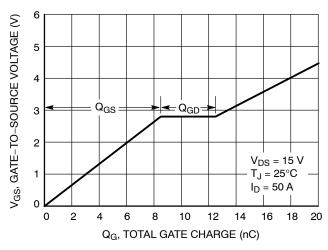


Figure 8. Gate-to-Source vs. Total Charge

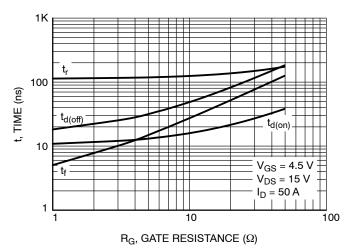


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

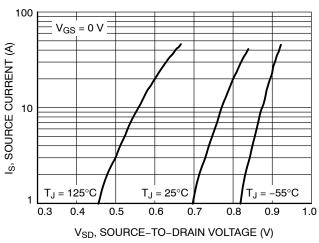


Figure 10. Diode Forward Voltage vs. Current

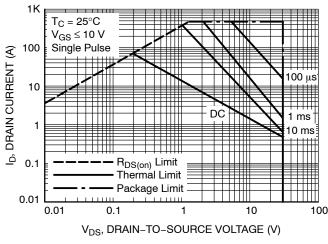


Figure 11. Maximum Rated Forward Biased Safe Operating Area

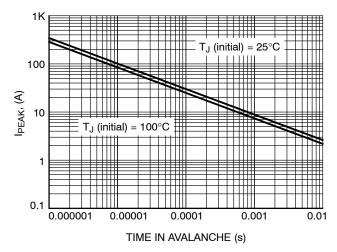


Figure 12. I<sub>PEAK</sub> vs. Time in Avalanche

# **TYPICAL CHARACTERISTICS**

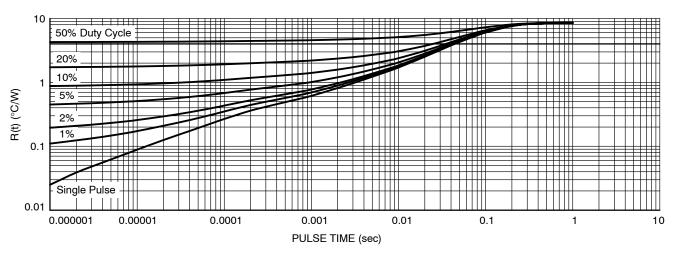
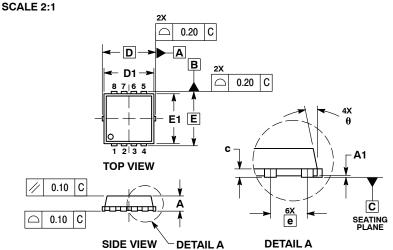


Figure 13. Thermal Characteristics



#### WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

**DATE 23 APR 2012** 



#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  CONTROLLING DIMENSION: MILLIMETERS.
  DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
  PROTRUSIONS OR GATE BURRS.

|     | MI       | LLIMETE  | RS   |       | INCHES   |       |  |
|-----|----------|----------|------|-------|----------|-------|--|
| DIM | MIN      | NOM      | MAX  | MIN   | NOM      | MAX   |  |
| Α   | 0.70     | 0.75     | 0.80 | 0.028 | 0.030    | 0.031 |  |
| A1  | 0.00     |          | 0.05 | 0.000 |          | 0.002 |  |
| b   | 0.23     | 0.30     | 0.40 | 0.009 | 0.012    | 0.016 |  |
| С   | 0.15     | 0.20     | 0.25 | 0.006 | 0.008    | 0.010 |  |
| D   |          | 3.30 BSC |      | 0     | .130 BSC | ;     |  |
| D1  | 2.95     | 3.05     | 3.15 | 0.116 | 0.120    | 0.124 |  |
| D2  | 1.98     | 2.11     | 2.24 | 0.078 | 0.083    | 0.088 |  |
| E   |          | 3.30 BSC |      | 0     | .130 BSC | BSC   |  |
| E1  | 2.95     | 3.05     | 3.15 | 0.116 | 0.120    | 0.124 |  |
| E2  | 1.47     | 1.60     | 1.73 | 0.058 | 0.063    | 0.068 |  |
| E3  | 0.23     | 0.30     | 0.40 | 0.009 | 0.012    | 0.016 |  |
| е   | 0.65 BSC |          |      | (     | 0.026 BS | 0     |  |
| G   | 0.30     | 0.41     | 0.51 | 0.012 | 0.016    | 0.020 |  |
| K   | 0.65     | 0.80     | 0.95 | 0.026 | 0.032    | 0.037 |  |
| L   | 0.30     | 0.43     | 0.56 | 0.012 | 0.017    | 0.022 |  |
| L1  | 0.06     | 0.13     | 0.20 | 0.002 | 0.005    | 0.008 |  |
| М   | 1.40     | 1.50     | 1.60 | 0.055 | 0.059    | 0.063 |  |
| θ   | 0 °      |          | 12 ° | 0 °   |          | 12 °  |  |



## **GENERIC MARKING DIAGRAM\***

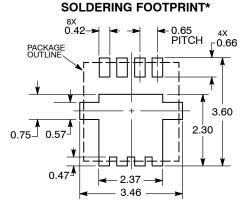


XXXXX = Specific Device Code = Assembly Location

= Year WW = Work Week = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking.

Pb-Free indicator, "G" or microdot " ■", may or may not be present.



DIMENSION: MILLIMETERS

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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| DESCRIPTION:     | WDFN8 3.3X3.3, 0.65P |   | PAGE 1 OF 1 |  |

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